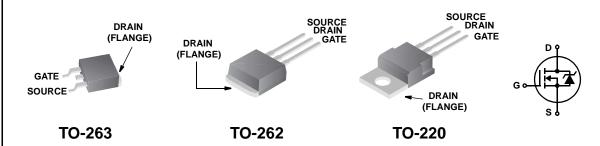


IRF630N/IRF630NS/IRF630NL

N-Channel Power MOSFETs 200V, 9.3A, 0.30Ω

Features

- Ultra Low On-Resistance
 - $r_{DS(ON)} = 0.200\Omega$ (Typ), $V_{GS} = 10V$
- · Simulation Models
 - Temperature Compensated PSPICE® and SABER[®] Electrical Models
 - Spice and SABER[©] Thermal Impedance Models
- · Peak Current vs Pulse Width Curve
- · UIS Rating Curve



MOSFET Maximum Ratings T_A = 25°C unless otherwise noted

| Symbol | Parameter | Ratings | | |
|-----------------------------------|--|------------|------|--|
| $V_{\rm DSS}$ | Drain to Source Voltage | 200 | V | |
| V _{GS} | Gate to Source Voltage | ±20 | V | |
| | Drain Current | | | |
| Continu | Continuous ($T_C = 25^{\circ}C$, $V_{GS} = 10V$) | 9.3 | Α | |
| | Continuous ($T_C = 100^{\circ}C$, $V_{GS} = 10V$) | 6.5 | Α | |
| | Pulsed | Figure 4 | Α | |
| E _{AS} | Single Pulse Avalanche Energy (Note 1) | 94 | mJ | |
| P _D | Power dissipation | 82 | W | |
| ט י | Derate above 25°C | 0.55 | W/°C | |
| T _J , T _{STG} | Operating and Storage Temperature | -55 to 175 | °C | |

Thermal Characteristics

| $R_{\theta JC}$ | Thermal Resistance Junction to Case TO-220, TO-262, TO-263 | 1.83 | °C/W |
|-----------------|---|------|------|
| $R_{\theta JA}$ | Thermal Resistance Junction to Ambient TO-220, TO-262, TO-263 | 62 | °C/W |
| $R_{\theta JA}$ | Thermal Resistance Junction to Ambient TO-263, 1in ² copper pad area | 40 | °C/W |

Package Marking and Ordering Information

| Device Marking | Device | Package | Reel Size | Tape Width | Quantity |
|----------------|----------|----------|-----------|------------|-----------|
| 630N | IRF630NS | TO-263AB | 330mm | 24mm | 800 units |
| 630N | IRF630NL | TO-262AA | Tube | N/A | 50 |
| 630N | IRF630N | TO-220AB | Tube | N/A | 50 |

| Symbol | Parameter | Test Con | ditions | Min | Тур | Max | Units |
|---------------------|---|---|--|-----|-------|-------|-------|
| Off Chara | cteristics | | | | | | |
| B _{VDSS} | Drain to Source Breakdown Voltage | I _D = 250μA, V _{GS} | S = 0V | 200 | - | - | V |
| | 7 0 . 1/1 5 . 0 | V _{DS} = 200V V _{GS} = 0V | | - | - | 25 | |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} = 160V | $T_{\rm C} = 150^{\rm o}$ | - | - | 250 | μΑ |
| I _{GSS} | Gate to Source Leakage Current | V _{GS} = ±20V | | - | - | ±100 | nA |
| On Chara | cteristics | | | | | | |
| V _{GS(TH)} | Gate to Source Threshold Voltage | $V_{GS} = V_{DS}, I_D =$ | 250μΑ | 2 | - | 4 | V |
| r _{DS(ON)} | Drain to Source On Resistance | I _D = 5.4A, V _{GS} = | | - | 0.200 | 0.300 | Ω |
| 9 _{fs} | Forward Transconductance | $V_{DS} = 50V, I_{D} = 50V$ | | 49 | - | - | S |
| Dynamic (| Characteristics | - | | | • | | |
| C _{ISS} | Input Capacitance | $V_{DS} = 25V, V_{GS} = 0V,$ f = 1MHz | | - | 1030 | - | pF |
| C _{OSS} | Output Capacitance | | | - | 120 | - | pF |
| C _{RSS} | Reverse Transfer Capacitance | | | - | 50 | - | pF |
| Q _{g(TOT)} | Total Gate Charge at 20V | $V_{GS} = 0V \text{ to}$ 20V | | | 59 | 78 | nC |
| Q _{g(10)} | Total Gate Charge at 10V | $V_{GS} = 0V \text{ to}$ 10V | V _{DD} = 100V I _D = 11A | - | 32 | 42 | nC |
| Q _{g(TH)} | Threshold Gate Charge | $V_{GS} = 0V \text{ to } 2V$ | | - | 2.0 | 3.2 | nC |
| Q _{gs} | Gate to Source Gate Charge | | 1 | - | 4.0 | - | nC |
| Q _{gd} | Gate to Drain "Miller" Charge | | | - | 11 | - | nC |
| Switching | Characteristics (V _{GS} = 10V) | | | | | | |
| t _{ON} | Turn-On Time | | | - | - | 32 | ns |
| t _{d(ON)} | Turn-On Delay Time | | | - | 9 | - | ns |
| t _r | Rise Time | $V_{DD} = 100V, I_{D} = 5.4A$ $V_{GS} = 10V, R_{GS} = 13\Omega$ | | - | 12 | - | ns |
| t _{d(OFF)} | Turn-Off Delay Time | | | - | 71 | - | ns |
| t _f | Fall Time | | | - | 19 | - | ns |
| t _{OFF} | Turn-Off Time | | | - | - | 135 | ns |
| Drain-Sou | rce Diode Characteristics | | | | | | |
| V _{SD} | Source to Drain Diode Voltage | I _{SD} = 5.4A | | - | - | 1.3 | V |
| t _{rr} | Reverse Recovery Time | $I_{SD} = 5.4A$, $dI_{SD}/dt = 100A/\mu s$ | | - | - | 176 | ns |
| Q _{RR} | Reverse Recovered Charge | $I_{SD} = 5.4A$, $dI_{SD}/dt = 100A/\mu s$ | | - | - | 813 | nC |

Starting T_J = 25°C, L = 6.5mH, I_{AS} = 5.4A.
 Pulse width ≤ 400μs; duty cycle ≤ 2%.`

Typical Characteristic 12 POWER DISSIPATION MULTIPLIER I_D, DRAIN CURRENT (A) 0.8 V_{GS} = 10V 0.6 0.4 0.2 0 0 25

25

50

Figure 1. Normalized Power Dissipation vs **Ambient Temperature**

T_C, CASE TEMPERATURE (°C)

Figure 2. Maximum Continuous Drain Current vs **Case Temperature**

100

T_C, CASE TEMPERATURE (°C)

125

150

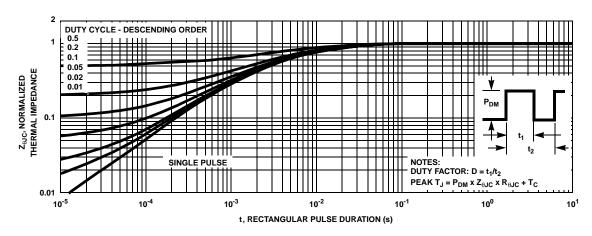


Figure 3. Normalized Maximum Transient Thermal Impedance

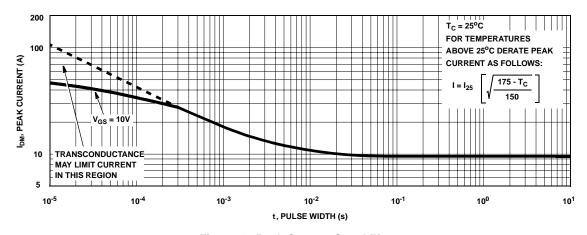
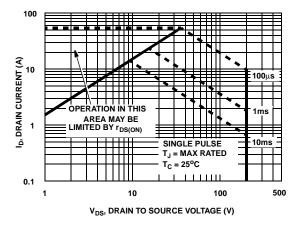


Figure 4. Peak Current Capability

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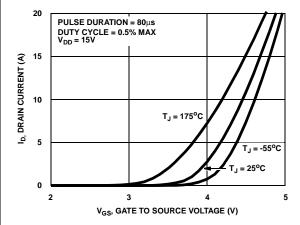


100

If R = 0 $t_{AV} = (L)(t_{AS})/(1.3^{\circ}RATED \ BV_{DSS} - V_{DD})$ If $R \neq 0$ $t_{AV} = (L/R)\ln[(t_{AS}^{\circ}R)/(1.3^{\circ}RATED \ BV_{DSS} - V_{DD}) + 1]$ STARTING $T_J = 25^{\circ}C$ $t_{AV} = (L/R)\ln[(t_{AS}^{\circ}R)/(1.3^{\circ}RATED \ BV_{DSS} - V_{DD}) + 1]$ 10 t_{AV} , TIME IN AVALANCHE (ms)

Figure 5. Forward Bias Safe Operating Area

Figure 6. Unclamped Inductive Switching Capability



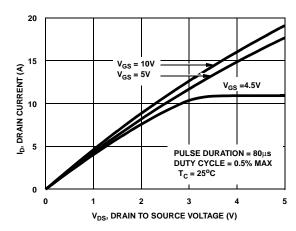
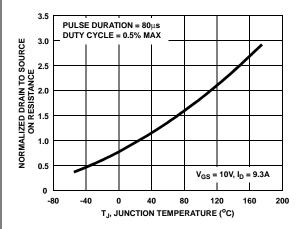


Figure 7. Transfer Characteristics

Figure 8. Saturation Characteristics



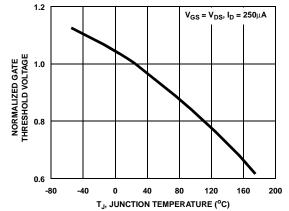
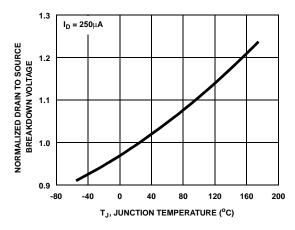


Figure 9. Normalized Drain to Source On Resistance vs Junction Temperature

Figure 10. Normalized Gate Threshold Voltage vs Junction Temperature

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Typical Characteristic (Continued)



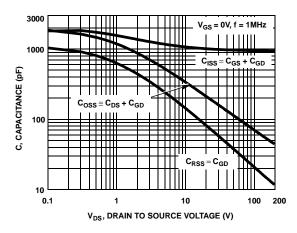


Figure 11. Normalized Drain to Source Breakdown Voltage vs Junction Temperature

Figure 12. Capacitance vs Drain to Source Voltage

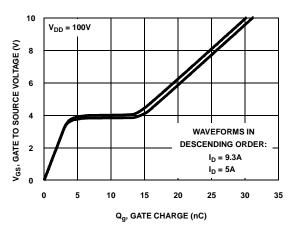


Figure 13. Gate Charge Waveforms for Constant Gate Currents

Test Circuits and Waveforms

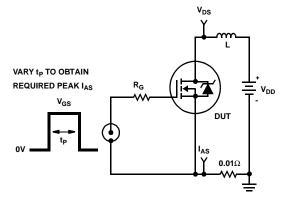


Figure 14. Unclamped Energy Test Circuit

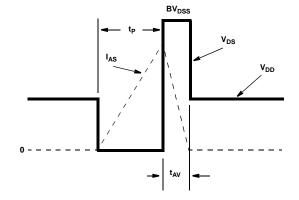


Figure 15. Unclamped Energy Waveforms

Test Circuits and Waveforms (Continued)

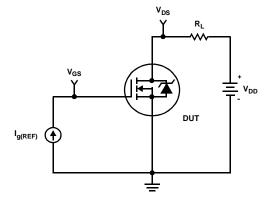


Figure 16. Gate Charge Test Circuit

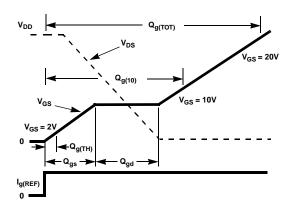


Figure 17. Gate Charge Waveforms

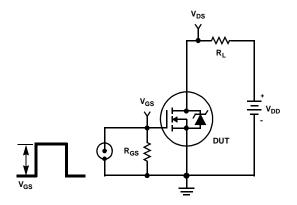


Figure 18. Switching Time Test Circuit

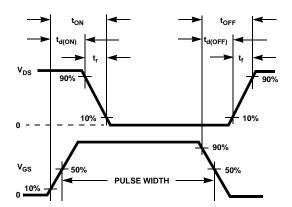


Figure 19. Switching Time Waveforms

Thermal Resistance vs. Mounting Pad Area

The maximum rated junction temperature, T_{JM} , and the thermal resistance of the heat dissipating path determines the maximum allowable device power dissipation, P_{DM} , in an application. Therefore the application's ambient temperature, T_A (°C), and thermal resistance $R_{\theta JA}$ (°C/W) must be reviewed to ensure that T_{JM} is never exceeded. Equation 1 mathematically represents the relationship and serves as the basis for establishing the rating of the part.

$$P_{DM} = \frac{(T_{JM} - T_A)}{Z_{\theta JA}} \tag{EQ. 1}$$

In using surface mount devices such as the TO-263 package, the environment in which it is applied will have a significant influence on the part's current and maximum power dissipation ratings. Precise determination of P_{DM} is complex and influenced by many factors:

- Mounting pad area onto which the device is attached and whether there is copper on one side or both sides of the board.
- The number of copper layers and the thickness of the board.
- 3. The use of external heat sinks.
- 4. The use of thermal vias.
- 5. Air flow and board orientation.
- For non steady state applications, the pulse width, the duty cycle and the transient thermal response of the part, the board and the environment they are in.

Fairchild provides thermal information to assist the designer's preliminary application evaluation. Figure 20 defines the $R_{\theta JA}$ for the device as a function of the top copper (component side) area. This is for a horizontally positioned FR-4 board with 1oz copper after 1000 seconds of steady state power with no air flow. This graph provides the necessary information for calculation of the steady state junction temperature or power dissipation. Pulse applications can be evaluated using the Fairchild device Spice thermal model or manually utilizing the normalized maximum transient thermal impedance curve.

Displayed on the curve are $R_{\theta JA}$ values listed in the Electrical Specifications table. The points were chosen to depict the compromise between the copper board area, the thermal resistance and ultimately the power dissipation, $P_{DM}. \label{eq:power}$

Thermal resistances corresponding to other copper areas can be obtained from Figure 20 or by calculation using Equation 2. $R_{\theta JA}$ is defined as the natural log of the area times a coefficient added to a constant. The area, in square inches is the top copper area including the gate and source pads.

$$R_{\theta JA} = 26.51 + \frac{19.84}{(0.262 + Area)}$$
 (EQ. 2)

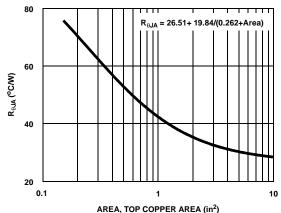


Figure 20. Thermal Resistance vs Mounting
Pad Area

```
PSPICE Electrical Model
.SUBCKT IRF630N 2 1 3;
                         rev May 2001
CA 12 8 1.6e-9
CB 15 14 1.75e-9
CIN 689.3e-8
                                                                                               LDRAIN
DBODY 7 5 DBODYMOD
                                                              DPLCAP
                                                                                                       DRAIN
                                                                                                m.
DBREAK 5 11 DBREAKMOD
                                                           10
DPLCAP 10 5 DPLCAPMOD
                                                                                               RLDRAIN
                                                                       RSLC1
                                                                                  DBREAK
EBREAK 11 7 17 18 227
                                                            RSLC2

EDS 14 8 5 8 1
                                                                         ESLC
EGS 13 8 6 8 1
ESG 6 10 6 8 1
                                                                       ้รก
EVTHRES 6 21 19 8 1
                                                                       RDRAIN
                                                                                        17
                                                                                             ▲ DBODY
                                                          8
EVTEMP 20 6 18 22 1
                                                     ESG(
                                                                                 EBREAK
                                                              EVTHRES
                                                                       21
IT 8 17 1
                                                                                ←MWEAK
                                       LGATE
                                                    EVTEMP
                                              RGATE
LDRAIN 2 5 1e-9
                                                      18 22
                                                                         ∣∰ммер
                                                   20
LGATE 1 9 5.12e-9
                                                                   MSTRC
                                       RI GATE
LSOURCE 3 7 4.24e-9
                                                                                               LSOURCE
                                                                   CIN
                                                                                                       SOURCE
                                                                          8
MMED 16 6 8 8 MMEDMOD
MSTRO 16 6 8 8 MSTROMOD
                                                                                  RSOURCE
MWEAK 16 21 8 8 MWEAKMOD
                                                                                              RLSOURCE
                                                                                     RBREAK
RBREAK 17 18 RBREAKMOD 1
                                                            14
13
                                                        <u>13</u>
8
                                                                  15
RDRAIN 50 16 RDRAINMOD 1.98e-1
RGATE 9 20 1.61
                                                                                             ₹RVTEMP
                                                            o S2B
RLDRAIN 2 5 10
                                                                  СВ
                                                                                              19
RLGATE 1 9 51.2
                                                CA
                                                                                 ıτ (∳
                                                                       14
RLSOURCE 3 7 42.4
                                                                                               VBAT
RSLC1 5 51 RSLCMOD 1e-6
                                                                     <u>5</u>
                                                       EGS
                                                                FDS
RSLC2 5 50 1e3
                                                                                8
RSOURCE 8 7 RSOURCEMOD 1e-2
RVTHRES 22 8 RVTHRESMOD 1
                                                                                     RVTHRES
RVTEMP 18 19 RVTEMPMOD 1
S1A 6 12 13 8 S1AMOD
S1B 13 12 13 8 S1BMOD
S2A 6 15 14 13 S2AMOD
S2B 13 15 14 13 S2BMOD
VBAT 22 19 DC 1
ESLC 51 50 VALUE={(V(5,51)/ABS(V(5,51)))*(PWR(V(5,51)/(1e-6*19),2.5))}
.MODEL DBODYMOD D (IS = 1e-12 N=1.02 RS = 7.75e-3 TRS1 = 2.5e-3 TRS2 = 2e-5 CJO = 8.5e-10 TT = 9.6e-6 M = 0.61
XTI=5.5)
.MODEL DBREAKMOD D (RS = 4. 2TRS1 = 1e- 3TRS2 = -8.9e-6)
.MODEL DPLCAPMOD D (CJO = 1.15e- 9IS = 1e-30 N = 10 M = 0.86)
.MODEL MMEDMOD NMOS (VTO = 3.25 KP = 5 IS = 1e-30 N = 10 TOX = 1 L = 1u W = 1u RG = 1.61)
.MODEL MSTROMOD NMOS (VTO = 3.65 KP = 28 IS = 1e-30 N = 10 TOX = 1 L = 1u W = 1u)
.MODEL MWEAKMOD NMOS (VTO = 2.8 KP = 0.05 IS = 1e-30 N = 10 TOX = 1 L = 1u W = 1u RG = 16.1 RS=.1)
.MODEL RBREAKMOD RES (TC1 =1.3e- 3TC2 = 2e-6)
.MODEL RDRAINMOD RES (TC1 = 1e- 2TC2 = 3.7e-5)
.MODEL RSLCMOD RES (TC1 = 4e-3 TC2 = 1e-6)
.MODEL RSOURCEMOD RES (TC1 = 1e-3 TC2 = 1e-6)
.MODEL RVTHRESMOD RES (TC1 = -2e-3 TC2 = -1.3e-5)
.MODEL RVTEMPMOD RES (TC1 = -3e- 3TC2 = 1.9e-6)
.MODEL S1AMOD VSWITCH (RON = 1e-5 ROFF = 0.1 VON = -7.5 VOFF= -.5)
.MODEL S1BMOD VSWITCH (RON = 1e-5 ROFF = 0.1 VON = -.5 VOFF= -7.5)
.MODEL S2AMOD VSWITCH (RON = 1e-5 ROFF = 0.1 VON = -0.1 VOFF= 0.2)
.MODEL S2BMOD VSWITCH (RON = 1e-5 ROFF = 0.1 VON = 0.2 VOFF= -0.1)
FNDS
NOTE: For further discussion of the PSPICE model, consult A New PSPICE Sub-Circuit for the Power MOSFET Featuring Global
Temperature Options; IEEE Power Electronics Specialist Conference Records, 1991, written by William J. Hepp and C. Frank
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Wheatlev.

SABER Electrical Model REV May 2001 template IRF630N n2,n1,n3 electrical n2,n1,n3 var i iscl dp..model dbodymod = (isl = 1e-12, rs = 7.75e-3, xti = 5.5, trs1 = 2.5e-3, trs2 = 2e-5, cjo = 8.5e-10, tt = 9.6e-6, m = 0.61) dp..model dbreakmod = (rs = 4.2, trs1 = 1e-3, trs2 = -8.9e-6)dp..model dplcapmod = (cjo = 1.15e-9, isl = 10e-30, nl=10, m = 0.86)m..model mmedmod = (type= n, vto = 3.25, kp = 5, isl = 1e-30, tox = 1) m..model mstrongmod = $(type=_n, vto = 3.65, kp = 28, isl = 1e-30, tox = 1)$ m..model mweakmod = (type= $_n$, vto = 2.8, kp = 0.05, isl = 1e-30, tox = 1, rs=0.1) sw_vcsp..model s1amod = (ron = 1e-5, roff = 0.1, von = -7.5, voff = -.5) sw vcsp..model s1bmod = (ron =1e-5, roff = 0.1, von = -.5, voff = -7.5) sw_vcsp..model s2amod = (ron = 1e-5, roff = 0.1, von = -0.1, voff = 0.2) LDRAIN sw_vcsp..model s2bmod = (ron = 1e-5, roff = 0.1, von = 0.2, voff = -0.1) DPLCAP 5 DRAIN c.ca n12 n8 = 1.6e-9 RLDRAIN c.cb n15 n14 = 1.75e-9RSLC1 c.cin n6 n8 = 9.3e-8RSLC2€ ISCL dp.dbody n7 n5 = model=dbodymod dp.dbreak n5 n11 = model=dbreakmod DBREAK 50 dp.dplcap n10 n5 = model=dplcapmod RDRAIN <u>6</u> 8 FSG i.it n8 n17 = 1DBODY **FVTHRES** 19 8 MWEAK LGATE **EVTEMP** I.Idrain n2 n5 = 1e-9RGATE + 18 22 GATE I.lgate n1 n9 = 5.12e-9**EBREA** I.Isource n3 n7 = 4.24e-9MSTR **RLGATE** m.mmed n16 n6 n8 n8 = model=mmedmod, l=1u, w=1u LSOURCE CIN SOURCE m.mstrong n16 n6 n8 n8 = model=mstrongmod, l=1u, w=1u 8 m.mweak n16 n21 n8 n8 = model=mweakmod, l=1u, w=1u RSOURCE RLSOURCE res.rbreak n17 n18 = 1, tc1 = 1.3e-3, tc2 = 2e-6 res.rdrain n50 n16 = 1.98e-5, tc1 = 1e-2, tc2 = 3.7e-5 RBREAK 14 13 18 res.rgate n9 n20 = 1.61res.rldrain n2 n5 = 10 RVTEMP res.rlgate n1 n9 = 51.2 CB 19 res.rlsource n3 n7 = 42.4 IT res.rslc1 n5 n51= 1e-6, tc1 = 4e-3, tc2 = -1e-6 **VBAT** res.rslc2 n5 n50 = 1e3 EGS res.rsource n8 n7 = 10e-3, tc1 = 1e-3, tc2 =1e-6 res.rvtemp n18 n19 = 1, tc1 = -2e-3, tc2 = -1.3e-5 res.rvthres n22 n8 = 1, tc1 = -3e-3, tc2 = 1.9e-6**RVTHRES** spe.ebreak n11 n7 n17 n18 = 227 spe.eds n14 n8 n5 n8 = 1 spe.egs n13 n8 n6 n8 = 1 spe.esq n6 n10 n6 n8 = 1 spe.evtemp n20 n6 n18 n22 = 1 spe.evthres n6 n21 n19 n8 = 1 sw_vcsp.s1a n6 n12 n13 n8 = model=s1amod sw_vcsp.s1b n13 n12 n13 n8 = model=s1bmod sw_vcsp.s2a n6 n15 n14 n13 = model=s2amod sw_vcsp.s2b n13 n15 n14 n13 = model=s2bmod v.vbat n22 n19 = dc=1 equations { i (n51->n50) +=iscl iscl: v(n51,n50) = ((v(n5,n51)/(1e-9+abs(v(n5,n51))))*((abs(v(n5,n51)*1e6*19))** 2.5))

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SPICE Thermal Model JUNCTION REV May 2001 IRF630N CTHERM1 th 6 8.0e-4 CTHERM2 6 5 2.6e-3 RTHERM1 CTHERM1 CTHERM3 5 4 3.5e-3 CTHERM4 4 3 5.2e-3 CTHERM5 3 2 7.0e-3 CTHERM6 2 tl 3.3e-2 6 RTHERM1 th 6 1.0e-3 RTHERM2 6 5 4.5e-3 RTHERM3 5 4 4.2e-2 RTHERM2 CTHERM2 RTHERM4 4 3 2.5e-1 RTHERM5 3 2 3.9e-1 RTHERM6 2 tl 5.0e-1 5 SABER Thermal Model RTHERM3 CTHERM3 SABER thermal model IRF630N template thermal_model th tl thermal_c th, tl ctherm.ctherm1 th 6 = 8.0e-4 ctherm.ctherm2 65 = 2.6e-3ctherm.ctherm3 5 4 = 3.5e-3RTHERM4 CTHERM4 ctherm.ctherm4 4 3 = 5.2e-3 ctherm.ctherm5 32 = 7.0e-3ctherm.ctherm6 2 tl = 3.3e-2 3 rtherm.rtherm1 th 6 = 1.0e-3rtherm.rtherm2 65 = 4.5e-3rtherm.rtherm3 5 4 = 4.2e-2CTHERM5 RTHERM5 rtherm.rtherm4 4 3 = 2.5e-1 rtherm.rtherm5 3 2 = 3.9e-1 rtherm.rtherm6 2 tl = 5.0e-1 2 RTHERM6 CTHERM6

CASE

tl

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